


<b>Search Notes</b>  	<b>Application/Control No.</b>  10568100	<b>Applicant(s)/Patent Under Reexamination</b>  SHIRAISHI, SATORU
	<b>Examiner</b>  KRISTEN C MATTER	<b>Art Unit</b>  3771

SEARCHED			
Class	Subclass	Date	Examiner
601	22, 27-32, 84, 90, 93, 94, 98, 103, 104, 112, 115, 122, 126, 127, 133, 134, 146, 149,-152	9/14/09	KCM

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search, see attached EAST text search strategy	9/14/09	KCM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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